

Notice of References Cited	Application/Control No. 10/648,401		Applicant(s)/Patent Under Reexamination LEE, SEOK-WOO	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,168,980	01-2001	Yamazaki et al.	438/162
	B	US-6,246,095	06-2001	Brady et al.	257/411
	C	US-6,436,848	08-2002	Ramkumar, Krishnaswamy	438/777
	D	US-6,624,468	09-2003	Takebuchi, Masataka	257/321
	E	US-6,610,374	08-2003	Tsai et al.	427/554
	F	US-5,510,146	04-1996	Miyasaka, Mitsutoshi	438/151
	G	US-6,071,796	06-2000	Voutsas, Tolis	438/487
	H	US-6,730,368	05-2004	Kawamura, Shinichi	427/554
	I	US-6,657,154	12-2003	Tanabe et al.	219/121.6
	J	US-6,211,098	04-2001	Twu et al.	438/787
	K	US-6,261,934	07-2001	Kraft et al.	438/592
	L	US-5,371,383	12-1994	Miyata et al.	257/77
	M	US-6,294,219	09-2001	Tsai et al.	427/314

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Stanley Wolf and Richard N. Tauber, Silicon Processing For The VLSI Era, Second Edition, pgs. 180-181
	V	Stanley Wolf and Richard N. Tauber, Silicon Processing For the VLSI Era, Vol. I, pgs. 169 and 171-172
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,326,258	12-2001	Iizuka, Toshihiro	438/239
	B	US-6,268,631	07-2001	Fukada et al.	257/347
	C	US-6,017,779	01-2000	Miyasaka, Mitsutoshi	438/149
	D	US-6,482,752	11-2002	Yamazaki et al.	438/758
	E	US-6,335,232	01-2002	Ohori et al.	438/158
	F	US-6,335,542	01-2002	Miyasaka, Mitsutoshi	257/66
	G	US-6,077,758	06-2000	Zhang et al.	438/486
	H	US-5,840,600	11-1998	Yamazaki et al.	438/151
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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